## Application/Control No. Applicant(s)/Patent Under Reexamination 09/652,159 LIU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Vanel Frenel 3626 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-6,386,451 05-2002 Sehr, Richard P. Α 235/384 US-2001/0028295 10-2001 BRINKMEYER et al. В 340/5.25 US-5,726,885 03-1998 Klein et al. С 455/456.6 US-D Ε US-US-F US-G US-Н US-١ US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν O Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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